

Notice of References Cited	Application/Control No. 10/500,109	Applicant(s)/Patent Under Reexamination VAN EIJK ET AL.	
	Examiner Stephanie K. Mummert, Ph.D.	Art Unit 1637	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	N	EP1130113	05-2001	Netherlands	SCHOUTEN et al.	C12Q 1/68
	O					
	P					
	Q					
	R					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Tang et al. (Nucleic Acids Research, 1995, vol. 23, no. 16, p. 3126-3131)
	V	Vos et al. (Nucleic Acids Research, 1995, vol. 23, p. 4407-44014)
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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